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APPLICATION NO.	F	ILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.		
09/942,323		08/29/2001	Walter L. Moden	3089.2US (96-0734.2)	3089.2US (96-0734.2) 9742		
24247	7590	10/15/2002					
TRASK BRITT				EXAMINER			
P.O. BOX 2 SALT LAK		JT 84110		LEE, HSII	LEE, HSIEN MING		
				ART UNIT	PAPER NUMBER		
				2823			
				DATE MAILED: 10/15/2002			

Please find below and/or attached an Office communication concerning this application or proceeding.

€' 1		Application No.	Applicant(s)	,				
•		09/942,323	MODEN ET AL.					
	Office Action Summary	Examiner	Art Unit					
		Hsien-Ming Lee	2823					
Period fo	The MAILING DATE of this communication app or Reply	ears on the cover sheet with the c	orrespondence address	:				
THE I - Exter after - If the - If NO - Failur - Any r	ORTENED STATUTORY PERIOD FOR REPLY MAILING DATE OF THIS COMMUNICATION. Insions of time may be available under the provisions of 37 CFR 1.13 SIX (6) MONTHS from the mailing date of this communication. Period for reply specified above is less than thirty (30) days, a reply period for reply is specified above, the maximum statutory period to reply within the set or extended period for reply will, by statute eply received by the Office later than three months after the mailing and patent term adjustment. See 37 CFR 1.704(b).	36(a). In no event, however, may a reply be timed within the statutory minimum of thirty (30) day will apply and will expire SIX (6) MONTHS from a cause the application to become ABANDONE	nely filed s will be considered timely. the mailing date of this commun D (35 U.S.C. § 133).	ication.				
1)	Responsive to communication(s) filed on							
2a)□		is action is non-final.						
3)	Since this application is in condition for allowa closed in accordance with the practice under	ance except for formal matters, pr	rosecution as to the me	rits is				
Dispositi	on of Claims	,						
•	Claim(s) <u>1-65</u> is/are pending in the application							
	4a) Of the above claim(s) is/are withdraw	wn from consideration.						
5)⊠	Claim(s) <u>34-65</u> is/are allowed.							
6)⊠	Claim(s) <u>1-4 and 9</u> is/are rejected.							
7)⊠	Claim(s) <u>5-8 and 10-33</u> is/are objected to.							
-	Claim(s) are subject to restriction and/or on Papers	r election requirement.						
· · ·	The specification is objected to by the Examine	r						
•—	The drawing(s) filed on 29 August 2001 is/are:		v the Examiner					
ובשולטו								
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a). 11) The proposed drawing correction filed on is: a) approved b) disapproved by the Examiner.								
If approved, corrected drawings are required in reply to this Office action.								
12) The oath or declaration is objected to by the Examiner.								
Priority u	ınder 35 U.S.C. §§ 119 and 120							
13)	Acknowledgment is made of a claim for foreign	priority under 35 U.S.C. § 119(a)-(d) or (f).					
a)[☐ All b)☐ Some * c)☐ None of:							
	1. Certified copies of the priority documents	s have been received.						
	2. Certified copies of the priority documents have been received in Application No							
* S	3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received.							
	cknowledgment is made of a claim for domesti	·		ication).				
а	a) The translation of the foreign language provisional application has been received. 15) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121.							
Attachmen	•		-					
1) Notic	e of References Cited (PTO-892) e of Draftsperson's Patent Drawing Review (PTO-948) nation Disclosure Statement(s) (PTO-1449) Paper No(s)	5) Notice of Informal F	v (PTO-413) Paper No(s) Patent Application (PTO-152)					

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DETAILED ACTION

Claim Rejections - 35 USC § 102

1. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (e) the invention was described in-
- (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effect under this subsection of a national application published under section 122(b) only if the international application designating the United States was published under Article 21(2)(a) of such treaty in the English language; or
- (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that a patent shall not be deemed filed in the United States for the purposes of this subsection based on the filing of an international application filed under the treaty defined in section 351(a).
- 2. Claims 1-4, 9 are rejected under 35 U.S.C. 102(e) as being anticipated by Moden (US 5,733,800).

Moden in Figs. 2A-2B and related text expressly and inherently teaches the claimed method for applying viscous material to at least one semiconductor component, the method comprising:

providing a viscous material pool containing viscous material, the viscous material pool shaped such that an exposed surface of the viscous material is located in a precise location and including at least one upward facing opening, the at least upward facing opening exposing at least the exposed surface of the viscous material, wherein the pool is a space (sprue) 36 containing the melted viscous adhesive material 30 (thermoset resins; col. 6, line 4) when the material 30 is heated; the pool 36 has an upward-facing opening that faces up a plunger 32; and the exposed surface of the melted viscous material 30 is located at a precise location, i.e. the bottom (primary

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runner) 38 of the pool 36 which connects with a transversely-oriented secondary runners 40 and across gates 42 into and through mold cavities 44 (Fig. 2A);

- exposing at least the exposed surface of the melted viscous material, i.e. exposing the exposed surface of the heated viscous material by pressing the plunger 32 to force the melted viscous material 30 to run through the sprue 36 (Fig.2B);
- aligning at least one semiconductor component over the viscous material pool, i.e.
 aligning the die assembly 100 comprising dies 102 and attached lead frames 104 with
 the melted viscous material 30 (Fig.2B); and
- wetting a specific location of the at least one semiconductor component with the viscous material, i.e. wetting the die assembly 100 comprising dies 102 and attached lead frames 104 with the melted viscous material 30 by forcing the melted viscous material 30 across the secondary runners 40 through gates 42 (Fig.2B).

Allowable Subject Matter

- 3. Claims 34-65 are allowed.
- 4. Claims 5-8, 10-33 are objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.
- 5. The following is a statement of reasons for the indication of allowable subject matter:
- 6. The prior art of record, Moden (US 5,733,800), teaches the claimed method as recited in claims 1-4 and 9 as stated above, but at least neither teaches nor suggests: (1) biasing the semiconductor component downward proximate the viscous material in the viscous material pool; (2) providing one of a hydraulic biasing mechanism, pneumatic biasing mechanism, and

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electrically powered biasing mechanism configurated to place the one semiconductor component proximate the viscous material; (3) raising the viscous material pool upward proximate the semiconductor component; (4) leveling the exposed surface of the viscous material prior to wetting a specific location of the semiconductor component; and (5) exposing the exposed surface of the viscous material, the exposed surface of the viscous material having a height that extends above the height of the at least one peripheral edge.

7. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Hsien-Ming Lee whose telephone number is 703-305-7341. The examiner can normally be reached on M-F (9:00 \sim 5:00).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Wael Fahmy can be reached on 703-308-4918. The fax phone numbers for the organization where this application or proceeding is assigned are 703-305-0142 for regular communications and 703-305-0142 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is 703-308-0956.

Hsien Ming Lee October 4, 2002

LONG PHAM
PRIMARY EXAMINER